Rev. 1.1 — 26 April 2022

Application note

Document information

Information	Content
Keywords	FXLS8967, FXLS8974, Linear accelerometer, inclinometer
Abstract	This document explains how to use the FXLS8967 and FXLS8974 linear accelerometers as an inclinometer.



NXP Semiconductors

Using the FXLS8967 and FXLS8974 3-axis linear accelerometers as an inclinometer

Revision history

Revision	Date	Description
1.1	20220426	 Global change: Revised "FXLS8964" to "FXLS8967 and FXLS8974." <u>Section 1</u>: Revised third paragraph.
1	20220127	Initial release

1 Introduction

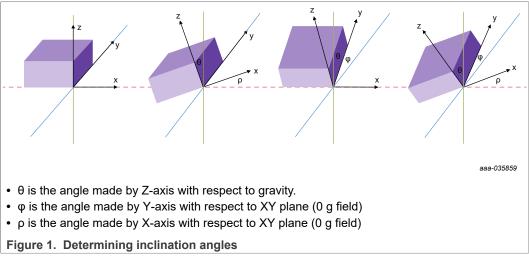
An inclinometer is a device capable of measuring precise angles (for example, tilt) of an object. One way to measure tilt angles is by using an accelerometer and local gravitational field as a reference. Accelerometers can be used to measure both static and dynamic acceleration forces. Dynamic acceleration measurement implies linear acceleration, deceleration, or vibrations for example. Tilt is considered essentially a static measurement since gravity is the only acceleration measured and used as a reference. Motion, if any, is generally at a slow rate. The underlying assumption in using an accelerometer as an inclinometer is that linear acceleration is essentially absent and that the pitch and roll angles can be measured against the rotated gravitational field vector. Therefore, the inclinometer uses the gravity vector and its projection on accelerometer axes to calculate tilt angle.

Inclination or tilt measurement has a number of useful applications in various fields. Examples include utility meter tamper detection, equipment leveling, asset tracking, orientation, combustion electricity generator tilt safety switch, and industrial motor to load alignment leveling.

This application note determines and demonstrates the accuracy of the NXP low power accelerometers such as FXLS8967 and FXLS8974, used as an inclinometer. It shows typical performance measured on two FXLS8967 demokits after a simple calibration procedure. Since FXLS8967 and FXLS8974 are 3-axis linear accelerometers, the procedure for calculating inclination angles from accelerometer outputs is derived for triple-axis use cases. The application note covers the recalibration procedure implemented to correct for typical thermal stresses due to printed circuit board soldering processes.

2 Triple-axis tilt angle calculation

One method to determine inclination angles with three axes is to calculate the angle for each axis with respect to the reference position individually. The reference position is the orientation in which the X and Y axes experience 0 g and Z-axis experiences 1 g. In this position, all tilt angles are zero. Consider the diagram in Figure 1.



Using basic trigonometry, the following equations are derived:

$$\rho = \sin^{-1}A_x \tag{1}$$

AN12630

$$\varphi = \sin^{-1}A_y \tag{2}$$

$$\theta = \cos^{-1}A_z \tag{3}$$

From basic trigonometry, the following is known:

$$\sin^{-1}x = \tan^{-1}\frac{x}{\sqrt{1-x^2}}$$
(4)

$$\cos^{-1}x = \tan^{-1}\frac{\sqrt{1-x^2}}{x}$$
 (5)

Applying Equation 4 to ρ and ϕ angles results in:

$$\rho = \tan^{-1} \frac{A_x}{\sqrt{1 - A_x^2}} \tag{6}$$

$$\varphi = \tan^{-1} \frac{A_y}{\sqrt{1 - A_y^2}} \tag{7}$$

Although the trigonometric equation manipulation is intuitive, these equations are not the best practical solution. In real-time use case, any amount of linear acceleration or sensor noise can lead to either A_x or A_y exceeding 1 g and the square-root then leads to an imaginary solution. Rewrite the above equations as shown by applying the constraint.

$$A_x^2 + A_y^2 + A_z^2 = 1 \ g^2 \tag{8}$$

$$\rho = \tan^{-1} \frac{A_x}{\sqrt{A_y^2 + A_z^2}} \tag{9}$$

$$\varphi = \tan^{-1} \frac{A_y}{\sqrt{A_x^2 + A_z^2}} \tag{10}$$

AN12630 Application note

AN12630

Using the FXLS8967 and FXLS8974 3-axis linear accelerometers as an inclinometer

$$\theta = \tan^{-1} \frac{\sqrt{A_x^2 + A_y^2}}{A_z} \tag{11}$$

The constraint is enforced to ensure that both numerator and denominator cannot be simultaneously zero. Therefore, avoid unstable tilt angle estimates. The above equations also produce constant sensitivity over a 360° rotation range.

The reason for switching from the simple inclination angle calculation using $\sin^{-1}x$ and $\cos^{-1}x$ to $\tan^{-1}x$ is for the improvement of tilt sensitivity and accuracy. Moreover, if angle measurement has to be done in the range of 0° to 180°, the sine function cannot provide unique solutions for angles in both quadrants.

In this application note, both roll and pitch angles are limited to the range of -90° to $+90^{\circ}$. Roll is the angle derived due to rotation about the X-axis and therefore in this case, roll is given by ϕ and pitch is the angle due to rotation about the Y-axis and is given by ρ .

Therefore, if the accelerometer measurement vector is defined as A = (Ax, Ay, Az), the following equations are used to compute the orientation angles:

$$Roll \ \varphi = \tan^{-1} \frac{A_y}{\sqrt{A_x^2 + A_z^2}}$$
(12)

$$Pitch \ \rho = \tan^{-1} \frac{A_x}{\sqrt{A_y^2 + A_z^2}}$$
(13)

Note: The roll and pitch angles defined by these equations do not follow the traditional Aerospace convention.

3 Calibration

The calibration method used is a six-parameter calibration for offset and sensitivity done to correct for thermal stresses due to soldering. Refer to application note, AN4399^[2]. Let the accelerometer outputs normalized to the units of g be A_x , A_y and A_z . Let the gain or the sensitivity parameters be W_{xx} , W_{yy} and W_{zz} . Let the offset parameters be V_x , V_y and V_z . If the calibrated acceleration outputs are given by A_{xc} , A_{yc} and A_{zc} , see Equation 14:

$$\begin{pmatrix} A_{xc} \\ A_{yc} \\ A_{zc} \end{pmatrix} = \begin{pmatrix} W_{xx} & 0 & 0 \\ 0 & W_{yy} & 0 \\ 0 & 0 & W_{zz} \end{pmatrix} \begin{pmatrix} A_x \\ A_y \\ A_z \end{pmatrix} + \begin{pmatrix} V_x \\ V_y \\ V_z \end{pmatrix}$$
(14)

The board is placed in six different orientations to apply acceleration equal to +1 g and -1 g in each of the X, Y, and Z directions. The accelerometer outputs are recorded and averaged over multiple readings for the six positions and converted into g units. The six calibration parameters are then given by the following equations:

$$W_{XX} = \frac{2}{A_X[0]A_X[1]}$$
(15)

$$W_{yy} = \frac{2}{A_y[2] \cdot A_y[3]}$$
(16)

$$W_{zz} = \frac{2}{A_{z}[4] A_{z}[5]}$$
(17)

© NXP B.V. 2022. All rights reserved

$$V_{x} = \frac{(A_{x}[0] + A_{x}[1])}{A_{x}[0] + A_{x}[1]}$$
(18)

$$V_{y} = \frac{\left(A_{y}[2] + A_{y}[3]\right)}{A_{y}[2] + A_{y}[3]}$$
(19)

$$V_{z} = \frac{(A_{z}[4]+A_{z}[5])}{A_{z}[4]+A_{z}[5]}$$
(20)

The numbers 0 to 5 denote the different orientations. In the first measurement, denoted by 0, only the X-value is taken, and the other values are not used. Similarly, in the last orientation, denoted by 5, only Z-value is considered, and X and Y values are not used.

Parameter	Acceleration
$A_x[0]$	X = +1 g
$A_x[1]$	X = -1 g
<i>Ay</i> [2]	Y = +1 g
<i>Ay</i> [3]	Y = -1 g
$A_{z}[4]$	Z = +1 g
$A_{z}[5]$	Z = -1 g

Using the above parameters, the calibrated accelerometer outputs can be obtained which in turn can be used to calculate roll and pitch angles.

The other method of calibration that can be used is the auto-zero calibration method. However, in this method, a 0 g reference is a must. Performing this calibration in all six positions results in increased accuracy compared to the simple calibration technique which requires the values of the device to be read in one position.

The former method of recalibration imitating the factory accelerometer calibration can be used even if the orientations do not involve a 0 *g* reference. For example, two measurement orientations that result in equal gravitational field in each axis, both positive and negative can be selected and the calibrated accelerometer output can then be calculated. This is an optimum solution since it requires just two orientations to calculate six parameters. Six measurement orientations are however chosen since it is simpler to align the board in the given six orientations than in the two orientations with equal gravitational field. The drawback of six measurement orientations is that eighteen measurements are obtained of which only six are used. Thus, the ease of alignment of the board trades off with the number of measurements that are taken and used.

Both the above mentioned calibration methods for six measurement orientations have been assessed in terms of flash and SRAM memory usage. Since the number of computations in the auto-zero calibration method might be more and might use more variables than the other calibration method, its memory usage is found to be 20 % more, comparatively and so this application note mostly focuses on factory calibration method for gain and offset.

4 Results

The above mentioned tilt angle calculation and calibration procedures were implemented on FXLS8967 shield board paired with KL25Z MCU board. A custom 2-axis Tilt table (see Figure 2) was used to orient the part in different positions between +1 g and -1 g on each axis. The flip-axis table contains motor encoders with a resolution of 40,000 counts per 360 degrees. Thus, every degree has a resolution of 111.11 counts or sub 0.01° resolution.

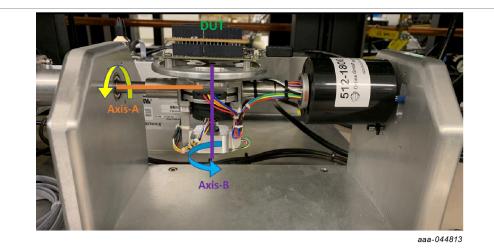


Figure 2. Two axis tilt table

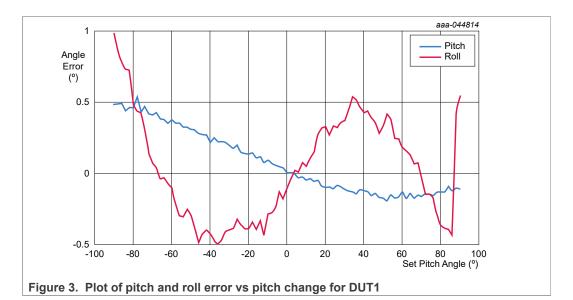
In order to avoid that the measurement table intrinsic imperfections (such as orthogonality error of its two axes and levelling error of the horizontal axis), a precision "golden" accelerometer was used to provide the reference acceleration and "true" angles. This precision accelerometer absolute accuracy in term of pitch and roll angles is typically better than 0.1°.

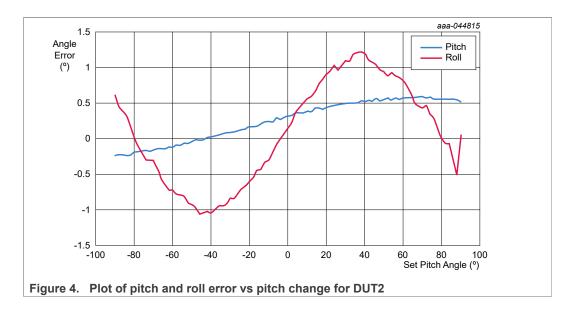
First, sensor calibration is performed using the six nominal orientations as described in <u>Section 3</u>. This initial phase provides the sensor offset and sensitivity correction coefficients that are used subsequently to improve sensor measurement accuracy as per <u>Equation 14</u>.

Then sensor acceleration data readings were taken when varying the table A or B angles in the range of -90° to 90° with 2° increments. All measurements have been done at room temperature.

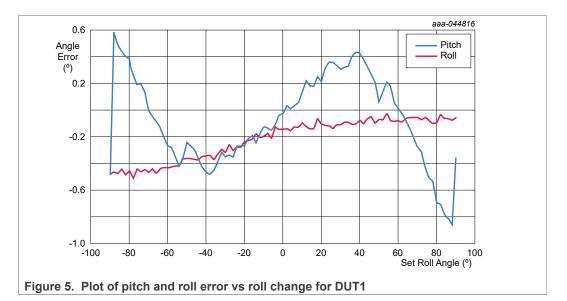
When table roll or pitch angles are varied between -90° and 90° , the error between actual and ideal pitch angle and roll angle was calculated by subtracting the angle derived from sensor calibrated data from the precision accelerometer angle assumed to be the ideal value.

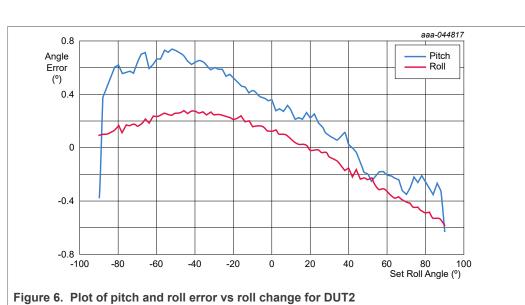
Two different devices (DUT1 and DUT2) were measured and their results are plotted in Figure 3 to Figure 6.





AN12630 Application note





When using a simple sensitivity and offset calibration procedure, the angle accuracy measured on the two FXLS8967 accelerometer samples, is typically better than 1° as observed on the plots.

5 Summary

From the data collected using the standard 6-positions calibration method described, the FXLS8967 already provides a fair accuracy for Pitch and Roll angles, hence is suitable for generic tilt-meter or inclinometer applications.

When higher accuracy is needed, including over a wide Temperature range, more sophisticated calibration and compensation methods can be implemented such as:

- correction of the Temperature drift (TCO, TCS)
- · calibration of the Sensor Cross axis sensitivity and misalignment errors

6 References

- [1] AN3461 Tilt sensing using a three-axis accelerometer https://www.nxp.com/docs/en/application-note/AN3461.pdf
- [2] AN4399 High-precision calibration of a three-axis accelerometer https://www.nxp.com/docs/en/application-note/AN4399.pdf
- [3] AN3107 Measuring tilt with low-g accelerometers https://www.nxp.com/docs/en/application-note/AN3107.pdf

7 Legal information

7.1 Definitions

Draft — A draft status on a document indicates that the content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included in a draft version of a document and shall have no liability for the consequences of use of such information.

7.2 Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer(s). NXP does not accept any liability in this respect.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Evaluation products — This product is provided on an "as is" and "with all faults" basis for evaluation purposes only. NXP Semiconductors, its affiliates and their suppliers expressly disclaim all warranties, whether express, implied or statutory, including but not limited to the implied warranties of non-infringement, merchantability and fitness for a particular purpose. The entire risk as to the quality, or arising out of the use or performance, of this product remains with customer.

In no event shall NXP Semiconductors, its affiliates or their suppliers be liable to customer for any special, indirect, consequential, punitive or incidental damages (including without limitation damages for loss of business, business interruption, loss of use, loss of data or information, and the like) arising out the use of or inability to use the product, whether or not based on tort (including negligence), strict liability, breach of contract, breach of warranty or any other theory, even if advised of the possibility of such damages.

Notwithstanding any damages that customer might incur for any reason whatsoever (including without limitation, all damages referenced above and all direct or general damages), the entire liability of NXP Semiconductors, its affiliates and their suppliers and customer's exclusive remedy for all of the foregoing shall be limited to actual damages incurred by customer based on reasonable reliance up to the greater of the amount actually paid by customer for the product or five dollars (US\$5.00). The foregoing limitations, exclusions and disclaimers shall apply to the maximum extent permitted by applicable law, even if any remedy fails of its essential purpose.

Translations — A non-English (translated) version of a document, including the legal information in that document, is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Security — Customer understands that all NXP products may be subject to unidentified vulnerabilities or may support established security standards or specifications with known limitations. Customer is responsible for the design and operation of its applications and products throughout their lifecycles to reduce the effect of these vulnerabilities on customer's applications and products. Customer's responsibility also extends to other open and/or proprietary technologies supported by NXP products for use in customer's applications. NXP accepts no liability for any vulnerability. Customer shall select products with security features that best meet rules, regulations, and standards of the intended application and make the

ultimate design decisions regarding its products and is solely responsible for compliance with all legal, regulatory, and security related requirements concerning its products, regardless of any information or support that may be provided by NXP.

NXP has a Product Security Incident Response Team (PSIRT) (reachable at <u>PSIRT@nxp.com</u>) that manages the investigation, reporting, and solution release to security vulnerabilities of NXP products.

7.3 Trademarks

Notice: All referenced brands, product names, service names, and trademarks are the property of their respective owners. **NXP** — wordmark and logo are trademarks of NXP B.V.

Figures

Fig. 1.	Determining inclination angles	3
Fig. 2.	Two axis tilt table	7
Fig. 3.	Plot of pitch and roll error vs pitch change	
	for DUT1	8
Fig. 4.	Plot of pitch and roll error vs pitch change	
•	for DUT2	8

Fig. 5.	Plot of pitch and roll error vs roll change for DUT1	۵
Fig. 6.	Plot of pitch and roll error vs roll change for	9
	DUT2	9

NXP Semiconductors

AN12630

Using the FXLS8967 and FXLS8974 3-axis linear accelerometers as an inclinometer

Contents

1	Introduction	3
2	Triple-axis tilt angle calculation	3
3	Calibration	
4	Results	7
5	Summary	9
6	References	
7	Legal information	

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© NXP B.V. 2022.

All rights reserved.

For more information, please visit: http://www.nxp.com For sales office addresses, please send an email to: salesaddresses@nxp.com

Date of release: 26 April 2022 Document identifier: AN12630